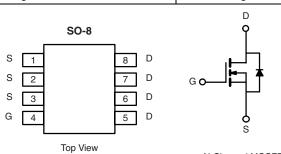


# Automotive N-Channel 30 V (D-S) 175 °C MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	30			
$R_{DS(on)}(\Omega)$ at $V_{GS} = 10 \text{ V}$	0.0135			
$R_{DS(on)}(\Omega)$ at $V_{GS} = 4.5 \text{ V}$	0.0200			
I <sub>D</sub> (A)	10			
Configuration	Single			



### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- Compliant to RoHS Directive 2002/95/EC
- AEC-Q101 Qualified<sup>d</sup>
- Find out more about Vishay's Automotive Grade Product Requirements at: www.vishay.com/applications





ROHS COMPLIANT HALOGEN FREE

ORDERING INFORMATION	
Package	SO-8
Lead (Pb)-free and Halogen-free	SQ4410EY-T1-GE3

N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b> T <sub>C</sub> = 25 °C, unless otherwise noted					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	30	V	
Gate-Source Voltage		V <sub>GS</sub>	V <sub>GS</sub> ± 20		
Continuous Drain Current <sup>a</sup>	T <sub>C</sub> = 25 °C	1	10		
	T <sub>C</sub> = 125 °C	l <sub>D</sub>	7.2	A	
Continuous Source Current (Diode Conduction) <sup>a</sup>		Is	2.3	^	
Pulsed Drain Current <sup>b</sup>		I <sub>DM</sub>	50	1	
Single Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	11	mJ	
Single Pulse Avalanche Current	L = 0.1 MH	I <sub>AS</sub>	15	Α	
Maximum Power Dissipation <sup>b</sup>	T <sub>C</sub> = 25 °C	D	2.5	W	
	T <sub>A</sub> = 125 °C	P <sub>D</sub>	1.3	] vv	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C	

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	LIMIT	UNIT	
Junction-to-Ambient	PCB Mount <sup>c</sup>	$R_{thJA}$	50	°C/W	
Junction-to-Foot (Drain)		$R_{thJF}$	22	C/VV	

#### Notes

- a. Package limited.
- b. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.
- c. When mounted on 1" square PCB (FR-4 material).
- d. Parametric verification ongoing.



SPECIFICATIONS T <sub>C</sub> = 25 °C, unless otherwise noted							
PARAMETER	SYMBOL	TES	TEST CONDITIONS		TYP.	MAX.	UNIT
Static							•
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60	-	-	V
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	$V_{GS}$ , $I_D = 250 \mu A$	1	-	3.0	, v
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA
		$V_{GS} = 0 V$	V <sub>DS</sub> = 60 V	-	-	1.0	μА
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$	$V_{DS} = 60 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	-	-	20	
		$V_{GS} = 0 V$	V <sub>DS</sub> = 60 V, T <sub>J</sub> = 175 °C	-	-	-	
On-State Drain Currenta	I <sub>D(on)</sub>	V <sub>GS</sub> = 10 V	$V_{DS} \ge 5 V$	20	-	-	Α
Drain-Source On-State Resistance <sup>a</sup>		V <sub>GS</sub> = 10 V	I <sub>D</sub> = 10 A	-	0.011	0.0135	Ω
		V <sub>GS</sub> = 10 V	I <sub>D</sub> = 6 A, T <sub>J</sub> = 125 °C	-	0.031	-	
	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 5 A	-	0.015	0.020	
		V <sub>GS</sub> = 10 V	I <sub>D</sub> = 6 A, T <sub>J</sub> = 175 °C	-	0.039	-	
Forward Transconductancea	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 10 A		-	38	-	S
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>		V <sub>DS</sub> = 25 V, f = 1 MHz	-	-	-	pF
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 V$		-	-	-	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	-	-	
Total Gate Charge <sup>c</sup>	Qg		V <sub>DS</sub> = 30 V, I <sub>D</sub> = 10 A	-	20	-	nC
Gate-Source Charge <sup>c</sup>	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V		-	37	-	
Gate-Drain Charge <sup>c</sup>	Q <sub>gd</sub>			-	7	-	
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>		$V_{DD} = 25 \text{ V}, R_1 = 25 \Omega$		19	-	- ns
Rise Time <sup>c</sup>	t <sub>r</sub>	V <sub>DD</sub> :			9	-	
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>	$I_D \cong 1 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 6 \Omega$		-	7	-	
Fall Time <sup>c</sup>	t <sub>f</sub>			-	40	-	
Source-Drain Diode Ratings and Char	acteristics T <sub>C</sub> = 2	25 °Cb					
Pulsed Current <sup>a</sup>	I <sub>SM</sub>			-	40	-	Α
Forward Voltage	V <sub>SD</sub>	I <sub>F</sub> = 2.3 A, V <sub>GS</sub> = 0 V		-	0.8	1.2	V
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 2.3 A, dI/dt = 100 A/μs		-	40	80	ns

#### **Notes**

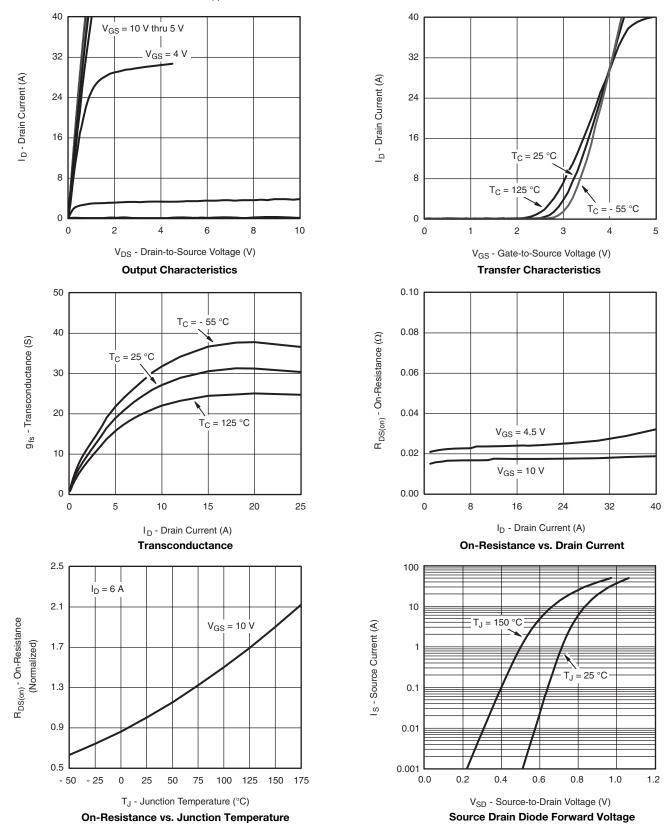
- a. Pulse test; pulse width  $\leq 300~\mu s,\,duty~cycle \leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



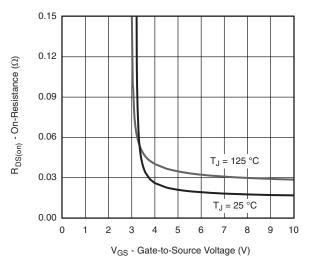


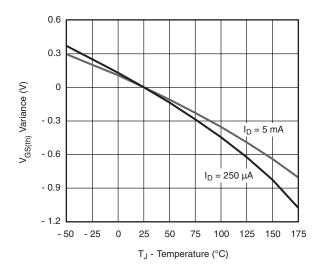
## **TYPICAL CHARACTERISTICS** $T_A = 25$ °C, unless otherwise noted





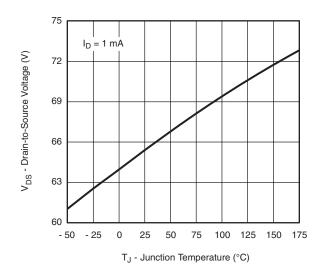
## **TYPICAL CHARACTERISTICS** $T_A = 25$ °C, unless otherwise noted





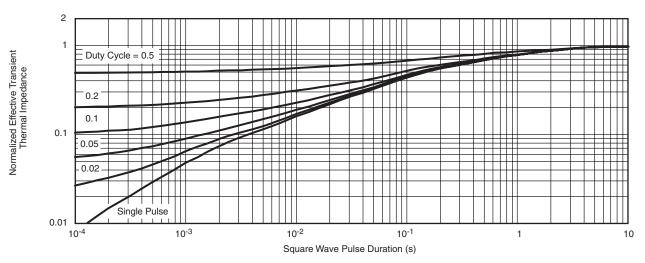
#### On-Resistance vs. Gate-to-Source Voltage

**Threshold Voltage** 



Drain Source Breakdown vs. Junction Temperature

## **THERMAL RATINGS** $T_A = 25$ °C, unless otherwise noted



Repetitive Avalanche Current (Peak) vs. Time in Avalanche at T<sub>A</sub> = 150 °C

#### Note

The characteristics shown in the graph Repetitive Avalanche Current (Peak) vs. Time in Avalanche is given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="https://www.vishay.com/ppg?65674">www.vishay.com/ppg?65674</a>.





Vishay

## **Disclaimer**

All product specifications and data are subject to change without notice.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained herein or in any other disclosure relating to any product.

Vishay disclaims any and all liability arising out of the use or application of any product described herein or of any information provided herein to the maximum extent permitted by law. The product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein, which apply to these products.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications unless otherwise expressly indicated. Customers using or selling Vishay products not expressly indicated for use in such applications do so entirely at their own risk and agree to fully indemnify Vishay for any damages arising or resulting from such use or sale. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

Product names and markings noted herein may be trademarks of their respective owners.

Revision: 18-Jul-08

Document Number: 91000 www.vishay.com